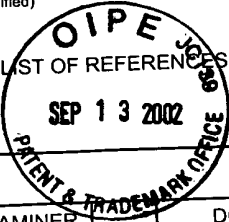


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 5244-0122-2		SERIAL NO. 09/453,935	
 LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Tetsuro MOTOYAMA et al.			
				FILING DATE 05/17/00		GROUP 2153	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
ORB	AA	5,908,493	06/01/99	KRYMSKY			
ORB	AB	5,412,779	05/02/95	MOTOYAMA			
ORB	AC	5,537,554	07/16/96	MOTOYAMA			
ORB	AD	5,819,110	10/06/98	MOTOYAMA			
ORB	AE	5,544,289	08/06/96	MOTOYAMA			
ORB	AF	5,818,603	10/06/98	MOTOYAMA			
ORB	AG	5,568,618	10/22/96	MOTOYAMA			
ORB	AH	5,649,120	07/15/97	MOTOYAMA			
ORB	AI	5,774,678	06/30/98	MOTOYAMA			
ORB	AJ	5,887,216	03/23/99	MOTOYAMA			
ORB	AK	6,085,196	07/04/00	MOTOYAMA et al.			
ORB	AL	6,279,015	08/21/01	FONG et al.			
ORB	AM	6,208,956	03/27/01	MOTOYAMA			
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO						
	AP						
	AQ						
	AR						
	AS						
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	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner <i>John R. Bravoli</i>					Date Considered 10-3-03		

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
5244-0122-2SERIAL NO.
09/453,935

LIST OF REFERENCES CITED BY APPLICANT

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May 17, 2000GROUP
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>[Signature]</i>	AA	6,539,422	03/2003	Hunt et al.			
<i>[Signature]</i>	AB	6,487,581	11/2002	Spence et al.			
<i>[Signature]</i>	AC	2003/0041093	02/2003	Yamane et al.			
<i>[Signature]</i>	AD	2003/0014505	01/2003	Ramberg et al.			
<i>[Signature]</i>	AE	6,041,041	03/2000	Ramanathan et al.			
<i>[Signature]</i>	AF	6,621,823	09/2003	Mellquist et al.			
	AG						
	AH						
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO					
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	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

[Signature]

Date Considered 4-1-04

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